

# Characterization of less-diffractive nano-scale beam from a ring aperture type plasmonic lens

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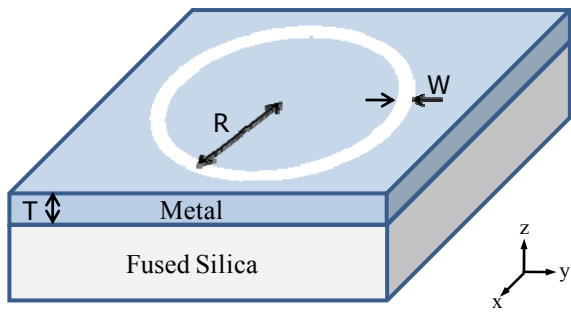
## Abstract

A perfect lens - the simplest imaging element in optics, which can be fabricated by corrected glass that is a free of aberration, had been thought as the best solution to achieve the smallest focus in a diffraction-limited system. To realize nano-scale focusing, however, recent progresses in micro/nano device fabrication techniques provided alternatives to circumvent polishing the lens more precisely or inventing slightly better dielectric by employing sub-wavelength structures, e.g. periodic or carefully designed apertures<sup>[1,2]</sup>, surface corrugations<sup>[3]</sup> or gratings coupled with holes<sup>[4]</sup>, which can diffract the incident light or excite and scatter surface plasmon (SP) waves more efficiently. While most of the technologies mentioned above use the SP waves that are strongly bounded to the near-field region of the metal/dielectric interface, i.e. normally within  $\sim\lambda/2$ , some research groups reported that nano-scale concentrated beam, formed by plasmonic lens(PL), can be extended to several wavelengths away from the metal surface, namely "mid-field", by careful choosing and designing of the metal<sup>[5,6]</sup> or metal/dielectric<sup>[7]</sup> structures.

In this manuscript, for the generation of less-diffractive nano-scale beam in the mid-field region, we characterize several critical parameters, i.e. material, aperture width, metal thickness, and aperture size, of the PL which contains a simple ring aperture as illustrated in Fig. 1. For the numerical analysis, we used TEMPEST, a Maxwell equations solver based on 3D FDTD(Finite-Difference-Time-Domain) simulation, and circularly polarized light of  $\lambda_0=405\text{nm}$  incident on the fused silica side of the PL device, and firstly investigated material effect on the nano-scale beaming. As shown in Fig. 2, several highly conductive metals such as Al, Ag, Ti, and Cr which also have been widely utilized in literatures<sup>[1-7]</sup> were compared by tracking focused beam intensity variation along with propagation axis(Z) of a simple  $2\mu\text{m}$ ( $R=1\mu\text{m}$ ) ring aperture made of each metal. In all the highly conductive metals investigated, less-diffractive beaming was observed (see Fig. 2(a)) and Al gave the highest intensity in the near-field region, however, as the observation point goes away from the metal surface,  $2\mu\text{m}$  ring aperture in Ag slab showed outstanding beaming performance up to  $Z=5.4\mu\text{m}$  which is over 10 fold longer than the incident wavelength. Upon setting the metal of interest with Ag, we analyzed the beaming performance with varied parameters of aperture width(W), metal thickness(T) and aperture radius(R). In Fig. 3, among various conditions, focused beam with the aperture parameter of W150T100 (i.e., 150nm aperture width and 100nm metal thickness) shows relatively uniform beam diameter of 280nm in the mid-field region of 1~4  $\mu\text{m}$ . Also, as described in Fig. 4, a longer radius of the ring aperture delays the less-diffractive uniform nano-scale beaming region slightly to the propagation direction. By focusing incident light to the less-diffractive nano-scale beam, the PL holds a great promise in maskless nanolithography, high-density data storage and optical efficiency improvement of light emitting diode(LED).

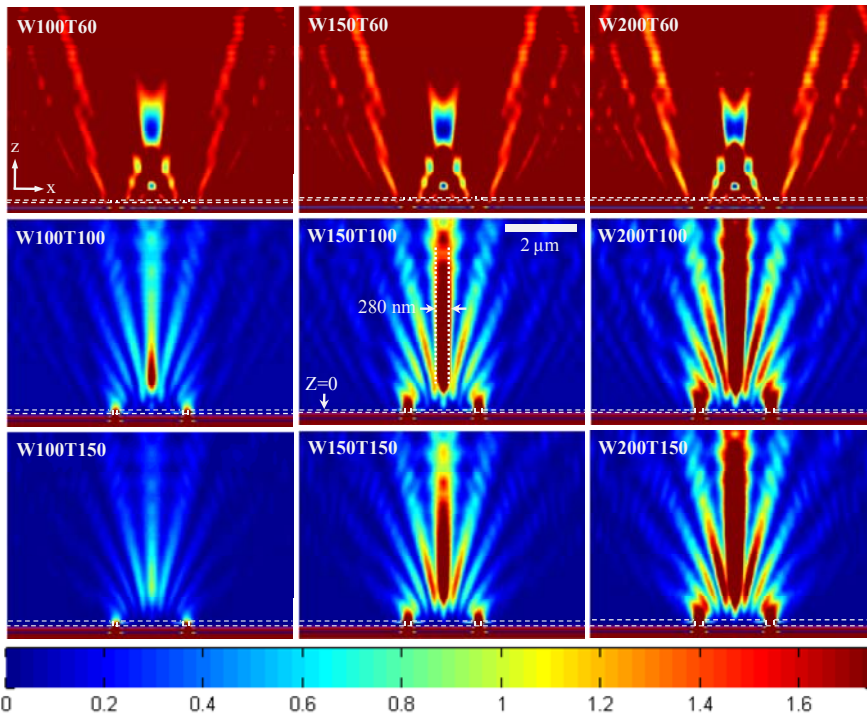
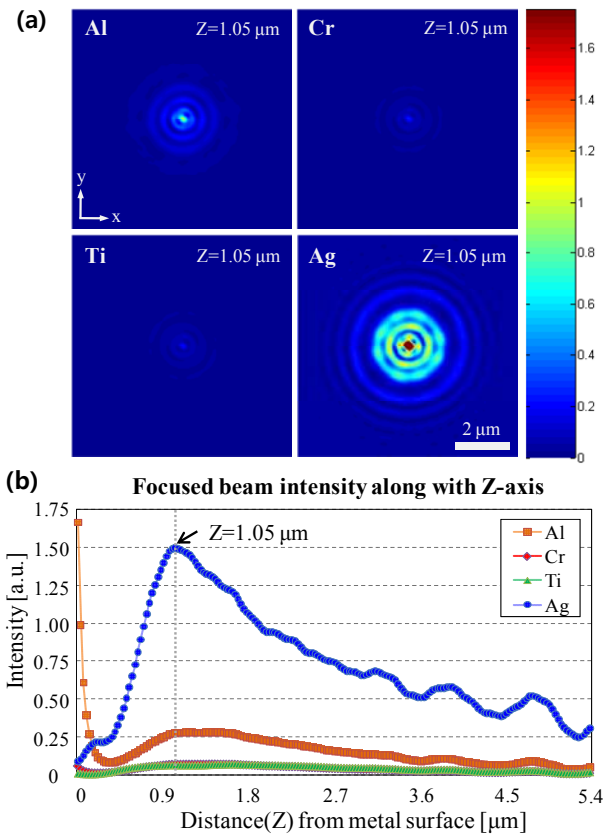
## References

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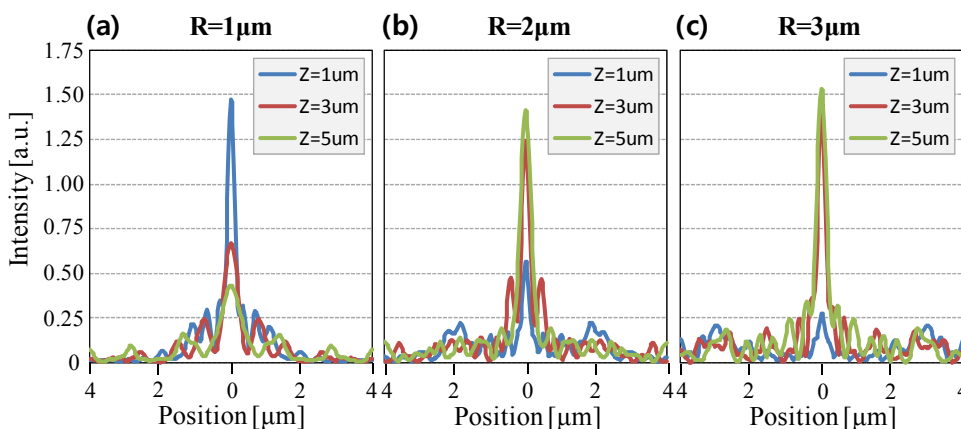


**Fig. 1** Schematic diagram of plasmonic lens with a ring aperture

**Fig. 2** Focused beam intensities for various metals (i.e. Al, Cr, Ti, and Ag) (a) Intensity distribution in XY-plane at  $Z=1.05\mu\text{m}$  (b) Intensity variation along with propagation axis (Z-axis)



**Fig. 3** Formation of less-diffractive nano-scale beam varying with aperture width (W) and metal thickness (T) in silver (Ag) slab



**Fig. 4** Propagating beam profiles at  $Z=1, 3, 5\mu\text{m}$  with various aperture radii (R), (a)  $R=1\mu\text{m}$ , (b)  $R=2\mu\text{m}$ , and (c)  $R=3\mu\text{m}$ , of Ag plasmonic lens